

SLOVENSKI STANDARD
oSIST prEN ISO 25178-73:2018
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**Specifikacija geometrijskih veličin izdelka (GPS) - Tekstura površine: ravna - 73.
del: Meritve materiala - Izrazi in definicije za površinske napake (ISO/DIS 25178-
73:2018)**

Geometrical product specifications (GPS) - Surface texture: Areal - Part 73: Material
measures - Terms and definitions for surface defects (ISO/DIS 25178-73:2018)

Geometrische Produktspezifikation (GPS) - Oberflächenbeschaffenheit: Flächenhaft -
Teil 73: Maßverkörperungen - Begriffe für Oberflächenfehler (ISO/DIS 25178-73:2018)

Spécification géométrique des produits (GPS) - État de surface: surfacique - Partie 73:
Défauts sur les mesures matérialisées - Termes et définitions: (ISO/DIS 25178-73:2018)

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Geometrical product specifications (GPS) — Surface texture: Areal —

Part 73:

Material measures — Terms and definitions for surface defects

*Spécification géométrique des produits (GPS) — État de surface: Surfamique —**Partie 73: Défauts sur les mesures matérialisées — Termes et définitions*

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The committee responsible for this document is Technical Committee ISO/TC 213, *Dimensional and geometrical product specifications and verification*.

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